

# SN54LS114A, SN54S114, SN74LS114A, SN74S114A DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET, COMMON CLEAR, AND COMMON CLOCK

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- Fully Buffered to Offer Maximum Isolation from External Disturbance
- Package Options Include Ceramic Carriers and Flat Packages in Addition to Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

## description

These devices contain two independent J-K negative-edge-triggered flip-flops. A low level at the preset and clear inputs sets or resets the outputs regardless of the levels of the other inputs. When preset and clear are inactive (high), data at the J and K inputs meeting the setup time requirements are transferred to the outputs on the negative-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold time interval, data at the J and K inputs may be changed without affecting the levels at the outputs. These versatile flip-flops can perform as toggle flip-flops by tying J and K high.

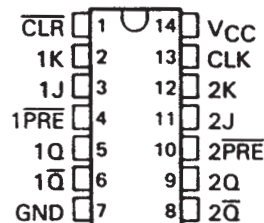
The SN54LS114A and SN54S114 are characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74LS114A and SN74S114A are characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

FUNCTION TABLE

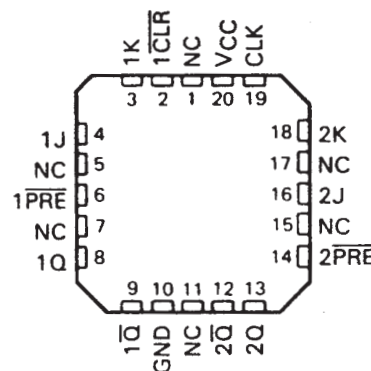
INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	$\bar{Q}$
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H <sup>†</sup>	H <sup>†</sup>
H	H	↓	L	L	Q <sub>0</sub>	$\bar{Q}_0$
H	H	↓	H	L	H	L
H	H	↓	L	H	L	H
H	H	↓	H	H	TOGGLE	
H	H	H	X	X	Q <sub>0</sub>	$\bar{Q}_0$

<sup>†</sup> The output levels in this configuration are not guaranteed to meet the minimum levels for  $V_{OH}$  if the lows at preset and clear are near  $V_{IL}$  minimum. Furthermore, this configuration is nonstable; that is, it will not persist when either preset or clear returns to its inactive (high) level.

SN54LS114A, SN54S114 . . . J OR W PACKAGE  
SN74LS114A, SN74S114A . . . D OR N PACKAGE  
(TOP VIEW)

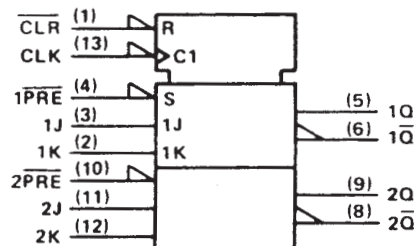


SN54LS114A, SN54S114 . . . FK PACKAGE  
(TOP VIEW)



NC—No internal connection

## logic symbol<sup>‡</sup>



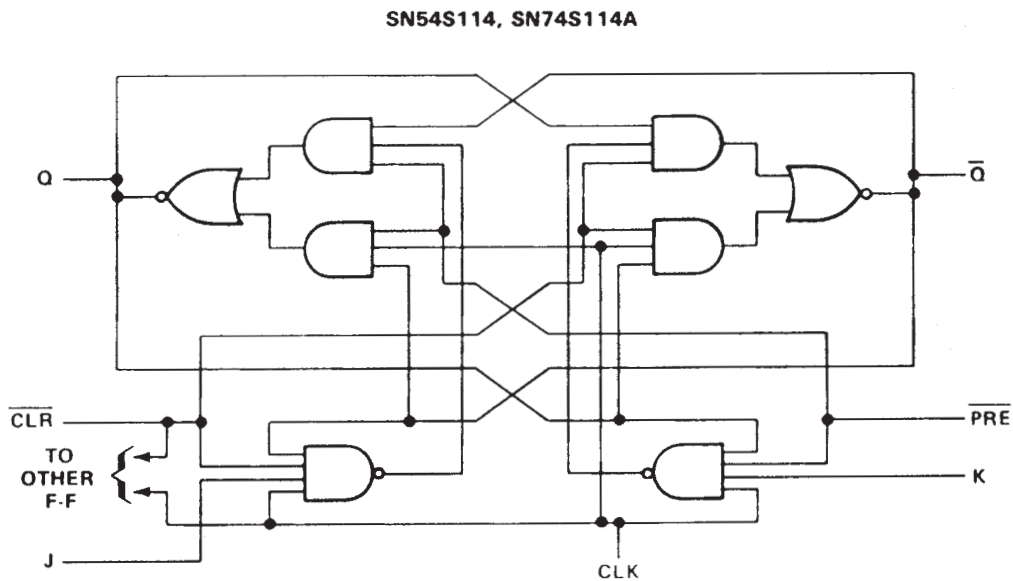
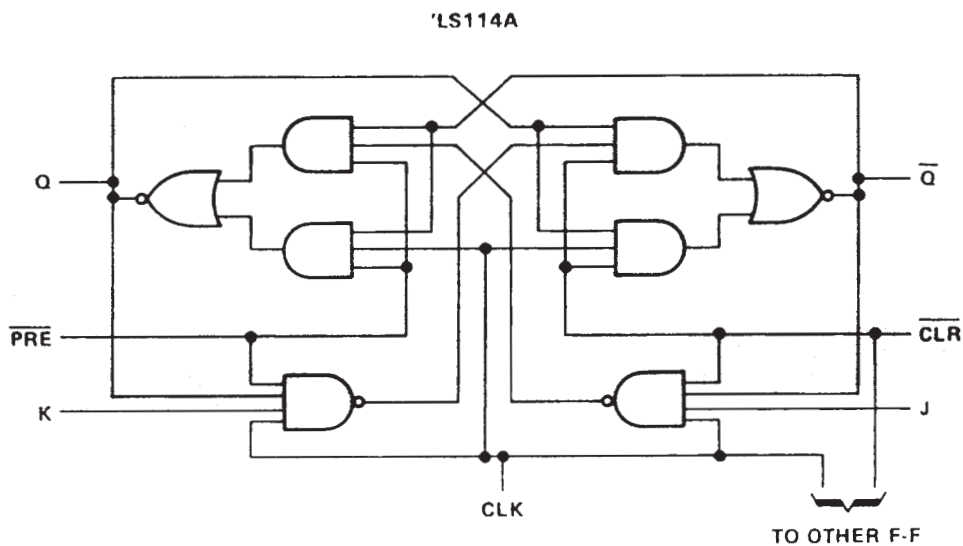
<sup>‡</sup>This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

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**logic diagram (positive logic)**

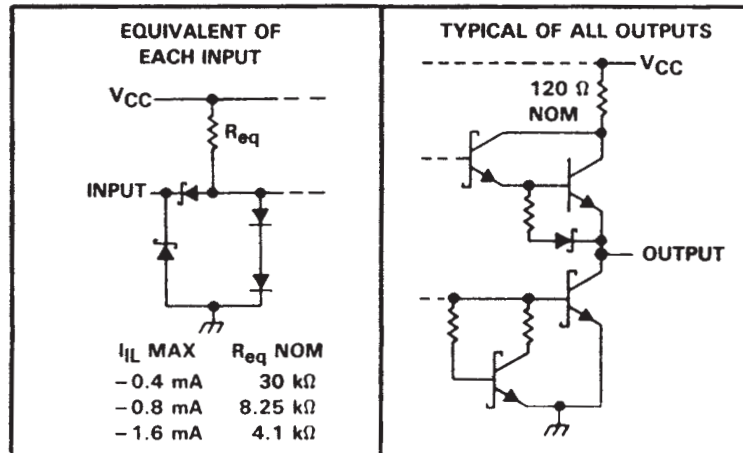


# SN54LS114A, SN54S114, SN74LS114A, SN74S114A DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET, COMMON CLEAR, AND COMMON CLOCK

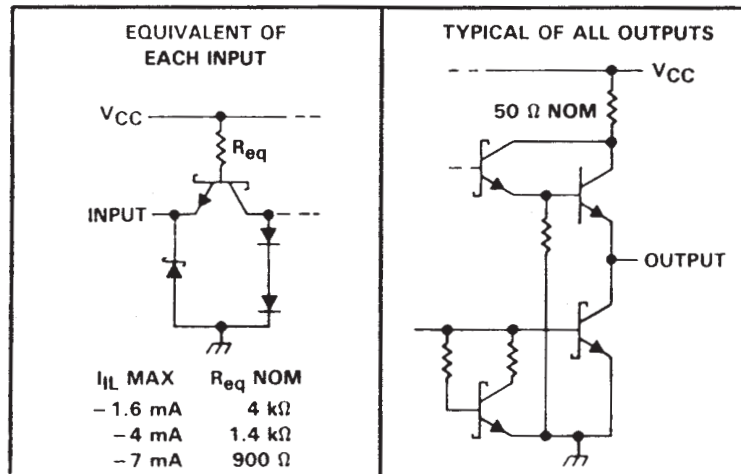
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## schematics of inputs and outputs

'LS114A



SN54S114, SN74S114A



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$ (see Note 1)'	7 V
Input voltage: 'LS114A	7 V
SN54S114, SN74S114A	5.5 V
Operating free-air temperature range: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

# SN54LS114A, SN54S114, SN74LS114A, SN74S114A DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET, COMMON CLEAR, AND COMMON CLOCK

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## recommended operating conditions

		SN54LS114A			SN74LS114A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage			0.7			0.8	V
I <sub>OH</sub>	High-level output current			-0.4			-0.4	mA
I <sub>OL</sub>	Low-level output current			4			8	mA
f <sub>clock</sub>	Clock frequency	0		30	0		30	MHz
t <sub>w</sub>	Pulse duration	CLK		20			20	ns
		PRE or CLR low		25			25	
t <sub>su</sub>	Set up time-before CLK↓	Data high or low		20			20	ns
		CLR inactive		25			25	
		PRE inactive		20			20	
t <sub>h</sub>	Hold time-data after CLK↓	0			0			ns
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54LS114A			SN74LS114A			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V <sub>IK</sub>	J or K	V <sub>CC</sub> = MIN,	I <sub>I</sub> = -18 mA			-1.5			-1.5	V
V <sub>OH</sub>	J or K	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	2.5	3.4		2.7	3.4		V
V <sub>OL</sub>	J or K	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,		0.25	0.4		0.25	0.4	V
	J or K	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,					0.35	0.5	
I <sub>I</sub>	J or K	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 7 V			0.1			0.1	mA
	CLR					0.6			0.6	
	PRE					0.3			0.3	
	CLK					0.8			0.8	
I <sub>IH</sub>	J or K	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 2.7 V			20			20	μA
	CLR					120			120	
	PRE					60			60	
	CLK					160			160	
I <sub>IL</sub>	J or K	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V			-0.4			-0.4	mA
	CLR					-1.6			-1.6	
	PRE					-0.8			-0.8	
	CLK					-1.6			-1.6	
I <sub>OS</sub> §		V <sub>CC</sub> = MAX,	See Note 2	-20		-100	-20		-100	mA
I <sub>CC</sub> (Total)		V <sub>CC</sub> = MAX,	See Note 3		4	6		4	6	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

NOTES: 2. For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with V<sub>O</sub> = 2.25 V and 2.125 V for the '54 family and the '74 family, respectively, with the minimum and maximum limits reduced to one half of their stated values.

3. With all outputs open, I<sub>CC</sub> is measured with the Q and Q̄ outputs high in turn. At the time of measurement, the clock input is grounded.



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switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (see Note 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{\max}$			$R_L = 2\text{ k}\Omega$ , $C_L = 15\text{ pF}$	30	45		MHz
$t_{PLH}$	CLR, PRE or CLK	Q or $\bar{Q}$			15	20	ns
$t_{PHL}$					15	20	ns

NOTE 4: Load circuit and voltage waveforms are shown in Section 1.

# SN54LS114A, SN54S114, SN74LS114A, SN74S114A DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET, COMMON CLEAR, AND COMMON CLOCK

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## recommended operating conditions

		SN54S114			SN74S114A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>IH</sub>	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage	0.8			0.8			V
I <sub>OH</sub>	High-level output current	-1			-1			mA
I <sub>OL</sub>	Low-level output current	20			20			mA
t <sub>w</sub>	Pulse duration	CLK	6		6			ns
		CLK low	6.5		6.5			
		PRE or CLR low	8		8			
t <sub>su</sub>	Setup time	Data high or low		7		7		ns
t <sub>h</sub>	Hold time-data after CLK↓	0			0			ns
T <sub>A</sub>	Operating free-air temperature	-55		125		0 70		°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54S114			SN74S114A			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V <sub>IK</sub>		V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA		-1.2			-1.2			V
V <sub>OH</sub>		V <sub>CC</sub> = MIN, I <sub>OH</sub> = -1 mA, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V		2.5	3.4		2.7	3.4		V
V <sub>OL</sub>		V <sub>CC</sub> = MIN, I <sub>OL</sub> = 20 mA, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V		0.5			0.5			V
I <sub>I</sub>		V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V		1			1			mA
I <sub>IH</sub>	J or K	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7 V		50			50			μA
	CLR			200			200			
	PRE			100			100			
	CLK			200			200			
I <sub>IL</sub>	J or K	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5 V		-1.6			-1.6			mA
	CLR			-14			-14			
	PRE			-7			-7			
	CLK			-8			-8			
I <sub>OS</sub> §		V <sub>CC</sub> = MAX		-40		-100	-40		-100	mA
I <sub>CC</sub> #		V <sub>CC</sub> = MAX, See Note 3		15 25		15 25				mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

# Values are average per flip-flop.

NOTE 3: With all outputs open, I<sub>CC</sub> is measured with the Q and Q̄ outputs high in turn. At the time of measurement, the clock input is grounded.



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switching characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$  (see Note 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{max}$			$R_L = 280\ \Omega, \quad C_L = 15\ \text{pF}$	80	125		MHz
$t_{PLH}$	$\overline{PRE}$ or $\overline{CLR}$	Q or $\overline{Q}$			4	7	ns
$t_{PHL}$	$\overline{PRE}$ or $\overline{CLR}$ (CLK high)	$\overline{Q}$ or Q			5	7	ns
	$\overline{PRE}$ or $\overline{CLR}$ (CLK low)				5	7	
$t_{PLH}$	CLK	Q or $\overline{Q}$			4	7	ns
$t_{PHL}$					5	7	ns

NOTE 4: Load circuit and voltage waveforms are shown in Section 1.

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